

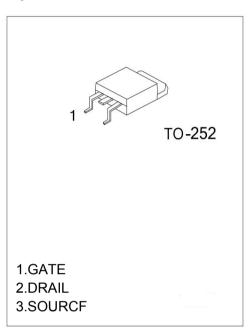
## N-Channel 60-V(D-S) Power MOSFET

V(BR)DSS	RDS(on)MAX	ID	
60 V	45mΩ@ 10 V	20A	
	50mΩ@ 4.5 V	20A	

## **General Description:**

The high voltage MOSFET uses an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition , this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes . The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power suppliers, converters and PWM motor controls , these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

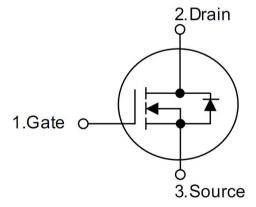
#### **Equivalent Circuit:**



**FEATURE:** 

- Power switching application
- \* Hard switched and high frequency circuits
- ※ Uninterruptible power supply
- ※ Fully characterized avalanche voltage and current
- ※ Excellent package for good heat dissipation
- \* Good stability and uniformity with high EAS





## Maximum ratings ( Ta=25 $^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-Source Voltage	VDS	60	V	
Gate-Source Voltage	VGS	±20	V	
Continuous Drain Current	ID	20	^	
Pulsed Diode Curren	IDM	40	Α	
Power Dissipation	PD	50	W	
Thermal Resistance from Junction to Ambient (t≤10s)	RθJA	100	°C/W	
Operating Junction	TJ	150	%	
Storage Temperature	TSTG	-55~+150	$\mathbb{C}$	



#### **MOSFET ELECTRICAL CHARACTERISTICS**

### Static Electrical Characteristics (Ta = 25 ℃ Unless Otherwise Noted)

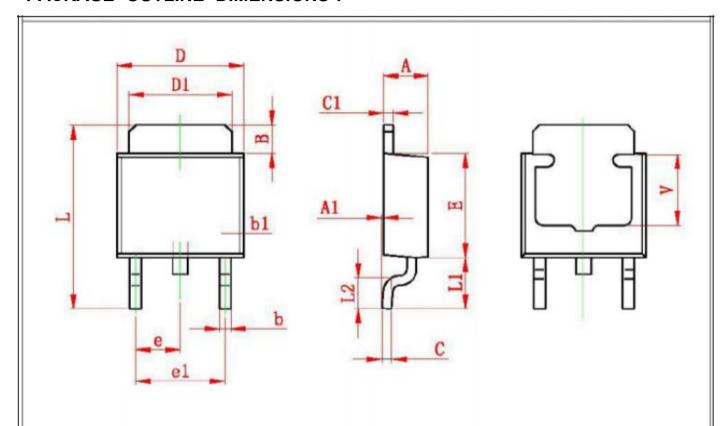
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Static					•	•
Drain-source breakdown voltage	V(BR)DSS	VGS = 0V, ID = 250μA	60			V
Gate-source threshold voltage	VGS(th)	VDS =VGS, ID = 250μA	1		3	V
Gate-source leakage	IGSS	VDS =0V, VGS = ±20V			±100	nA
Zero gate voltage drain current	IDSS	VDS = 60V, VGS =0V			1	μA
Drain-source on-state resistancea	DDG( )	VGS = 10V, ID = 10A		38	45	mΩ
	RDS(on)	VGS = 4.5V, ID = 5A		43	50	mΩ
Forward transconductancea	gfs	VDS = 25V, ID = 20A		10		S
Diode forward voltage	VSD	IS= 2A, VGS=0V		0.85	1.5	V
Dynamic						•
Input capacitance	Ciss			500		pF
Output capacitance	Coss	VDS = 25V,VGS =0V, f=1MHz		150		pF
Reverse transfer capacitanceb	Crss			82		pF
Total gate charge	Qg			31		nC
Gate-source charge	Qgs	VDS = 30V,VGS = 10V, ID = 20A		10		nC
Gate-drain charge	Qgd	.5 20.1		6		nC
Switchingb	•					•
Turn-on delay time	td(on)			10		ns
Rise time	tr	VDD= 30V		23		ns
Turn-off delay time	td(off)	RL= 25Ω, ID = 20A, VGEN= 10V,Rg= 25Ω		64		ns
Fall time	tf			31		ns
Drain-Source Diode Characteri	stics					
Continuous Source-Drain Diode Current	IS				20	А
Pulsed Diode forward Curren	ISM				80	Α

#### Note:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t < 10 sec.
- 3. Pulse Test : Pulse Width≤300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production testing.



# PACKAGE OUTLINE DIMENSIONS:



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
Α	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
В	1.350	1.650	0.053	0.065
b	0.500	0.700	0.020	0.028
b1	0.700	0.900	0.028	0.035
С	0.430	0.580	0.017	0.023
c1	0.430	0.580	0.017	0.023
D	6.350	6.650	0.250	0.262
D1	5.200	5.400	0.205	0.213
E	5.400	5.700	0.213	0.224
е	2.300 TYP		0.091 TYP	
e1	4.500	4.700	0.177	0.185
L	9.500	9.900	0.374	0.390
L1	2.550	2.900	0.100	0.114
L2	1.400	1.780	0.055	0.070
V	3.80 REF		0.150 REF	